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Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/602,326	PU ET AL.	
Examiner	Art Unit	
TAN Q. NGUYEN	3661	

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Class	Subclass	Date	Examiner
UPDATED	SEARCH (01/17/05)	8/19/2005	TN
709	217,218		
	219		
707	10,102		
	103R		
	103X		
	104.1		
701	210		

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Class	Subclass	Date	Examiner
701	200,210 21	8/19/2005	TN
709	201,219		
707	10,104.1		

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